



**N-Channel Enhancement-Mode  
Vertical DMOS FETs**

**Ordering Information**

BV <sub>DSS</sub> / BV <sub>DGS</sub>	R <sub>DS(ON)</sub> (max)	I <sub>D(ON)</sub> (min)	Order Number / Package	
			TO-39	TO-92
40V	8.0Ω	0.5A	—	—
60V	8.0Ω	0.5A	VN1306N2	—
100V	8.0Ω	0.5A	—	VN1310N3

**Features**

- Free from secondary breakdown
- Low power drive requirement
- Ease of paralleling
- Low C<sub>ISS</sub> and fast switching speeds
- Excellent thermal stability
- Integral Source-Drain diode
- High input impedance and high gain
- Complementary N- and P-channel devices

**Applications**

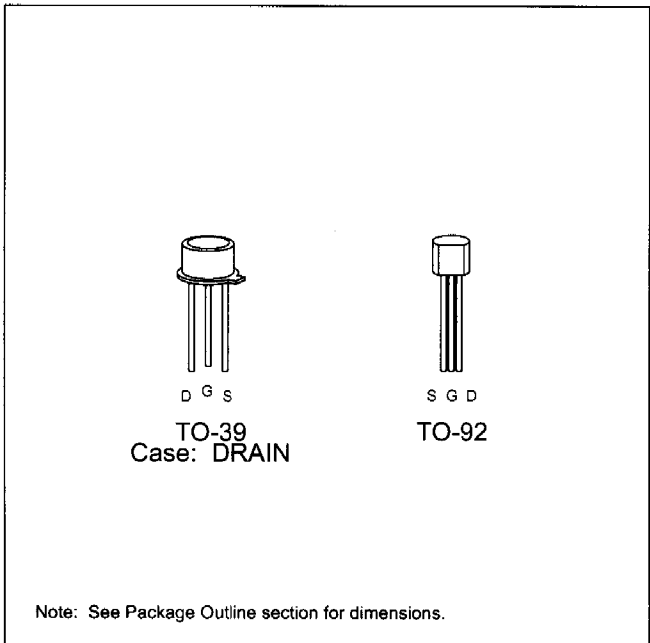
- Motor controls
- Converters
- Amplifiers
- Switches
- Power supply circuits
- Drivers (relays, hammers, solenoids, lamps, memories, displays, bipolar transistors, etc.)

**Absolute Maximum Ratings**

Drain-to-Source Voltage	BV <sub>DSS</sub>
Drain-to-Gate Voltage	BV <sub>DGS</sub>
Gate-to-Source Voltage	± 20V
Operating and Storage Temperature	-55°C to +150°C
Soldering Temperature*	300°C

\* Distance of 1.6 mm from case for 10 seconds.

**Package Options**



## Thermal Characteristics

Package	$I_D$ (continuous)*	$I_D$ (pulsed)	Power Dissipation @ $T_c = 25^\circ\text{C}$	$\theta_{jc}$ $^\circ\text{C/W}$	$\theta_{ja}$ $^\circ\text{C/W}$	$I_{DR}^*$	$I_{DRM}$
TO-39	0.4A	1.4A	3.0W	41	125	0.4A	1.4A
TO-92	0.25A	1.3A	1.0W	125	170	0.25A	1.3A

\*  $I_D$  (continuous) is limited by max rated  $T_j$ .

## Electrical Characteristics (@ $25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min	Typ	Max	Unit	Conditions
$BV_{DSS}$	Drain-to-Source Breakdown Voltage	VN1310	100		V	$V_{GS} = 0V, I_D = 1mA$
		VN1306	60			
		VN1304	40			
$V_{GS(th)}$	Gate Threshold Voltage	0.8		2.4	V	$V_{GS} = V_{DS}, I_D = 1mA$
$\Delta V_{GS(th)}$	Change in $V_{GS(th)}$ with Temperature		-3.9	-5.0	mV/ $^\circ\text{C}$	$V_{GS} = V_{DS}, I_D = 1mA$
$I_{GSS}$	Gate Body Leakage			100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
$I_{DSS}$	Zero Gate Voltage Drain Current			1	$\mu\text{A}$	$V_{GS} = 0V, V_{DS} = \text{Max Rating}$
				100	$\mu\text{A}$	$V_{GS} = 0V, V_{DS} = 0.8 \text{ Max Rating}$ $T_A = 125^\circ\text{C}$
$I_{D(ON)}$	ON-State Drain Current	0.25	0.6		A	$V_{GS} = 5V, V_{DS} = 25V$
		0.50	1.4			$V_{GS} = 10V, V_{DS} = 25V$
$R_{DS(ON)}$	Static Drain-to-Source ON-State Resistance		5.0	15	$\Omega$	$V_{GS} = 5V, I_D = 50mA$
			5.0	8.0		$V_{GS} = 10V, I_D = 500mA$
$\Delta R_{DS(ON)}$	Change in $R_{DS(ON)}$ with Temperature		0.8	2	%/ $^\circ\text{C}$	$V_{GS} = 10V, I_D = 500mA$
$G_{FS}$	Forward Transconductance	120			m $\Omega$	$V_{DS} = 25V, I_D = 500mA$
$C_{ISS}$	Input Capacitance		27	35	pF	$V_{GS} = 0V, V_{DS} = 25V$ $f = 1 \text{ MHz}$
$C_{OSS}$	Common Source Output Capacitance		13	15		
$C_{RSS}$	Reverse Transfer Capacitance		3	5		
$t_{d(ON)}$	Turn-ON Delay Time		2	5	ns	$V_{DD} = 25V$ $I_D = 500mA$ $R_{GEN} = 25\Omega$
$t_r$	Rise Time		2	5		
$t_{d(OFF)}$	Turn-OFF Delay Time		2	6		
$t_f$	Fall Time		2	5		
$V_{SD}$	Diode Forward Voltage Drop		1.0	1.3		
$t_{rr}$	Reverse Recovery Time		350		ns	$V_{GS} = 0V, I_{SD} = 0.5A$

### Notes:

- All D.C. parameters 100% tested at  $25^\circ\text{C}$  unless otherwise stated. (Pulse test: 300 $\mu\text{s}$  pulse, 2% duty cycle.)
- All A.C. parameters sample tested.

## Switching Waveforms and Test Circuit

